







SN74AHC08Q-Q1

SGDS010E - SEPTEMBER 1998 - REVISED MAY 2024

# SN74AHC08Q-Q1 Automotive Quadruple 2-Input Positive-and Gate

### 1 Features

- Qualified for automotive applications
- Operating range 2V to 5.5V V<sub>CC</sub>
- EPIC™ (Enhanced-Performance Implanted CMOS) process
- Latch-up performance exceeds 250 mA per JESD 17

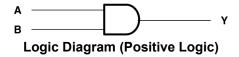
### 2 Description

This device is a quadruple 2-input positive-AND gate that performs the Boolean function  $Y + A \cdot B$  or  $Y = \overline{A}$ + B in positive logic.

#### **Package Information**

PART NUMBER	PACKAGE <sup>(1)</sup>	PACKAGE SIZE(2)	BODY SIZE(3)							
	D (SOIC, 14)	8.65mm × 6mm	8.65mm × 3.9mm							
SN74AHC08Q-Q1	PW (TSSOP, 14)	5.00mm × 6.4mm	5mm × 4.4mm							
	BQA (WQFN, 14)	3mm × 2.5mm	3mm × 2.5mm							

- For more information, see Section 9. (1)
- The package size (length × width) is a nominal value and includes pins, where applicable.
- The body size (length × width) is a nominal value and does not include pins.





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# 3 Pin Configuration and Functions

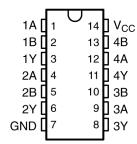


Figure 3-1. D or PW Package, 14-Pin SOIC or TSSOP (Top View)

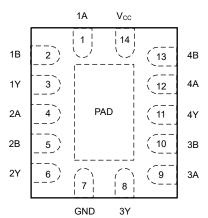


Figure 3-2. BQA Package, 14-Pin WQFN (Top View)

**Table 3-1. Pin Functions** 

P	IN	TVDE	DECODIDETION
NAME	NO.	TYPE	DESCRIPTION
1A	1	Input	Channel 1, Input A
1B	2	Input	Channel 1, Input B
1Y	3	Output	Channel 1, Output Y
2A	4	Input	Channel 2, Input A
2B	5	Input	Channel 2, Input B
2Y	6	Output	Channel 2, Output Y
GND	7	_	Ground
3Y	8	Output	Channel 3, Output Y
3A	9	Input	Channel 3, Input A
3B	10	Input	Channel 3, Input B
4Y	11	Output	Channel 4, Output Y
4A	12	Input	Channel 4, Input A
4B	13	Input	Channel 4, Input B
V <sub>CC</sub>	14	_	Positive Supply
Thermal Information —		_	The thermal pad can be connected to GND or left floating. Do not connect to any other signal or supply.



### 4 Specifications

### 4.1 Absolute Maximum Ratings

over operating free-air temperature range (unless otherwise noted)<sup>(1)</sup>

		<u> </u>	MIN	MAX	UNIT
V <sub>CC</sub>	Supply voltage range		-0.5	7	V
V <sub>I</sub> <sup>1</sup>	Input voltage range	Input voltage range		7	V
V <sub>O</sub> <sup>1</sup>	Output voltage range	Output voltage range		V <sub>CC</sub> + 0.5	V
I <sub>IK</sub>	Input clamp current	(V <sub>I</sub> < 0)		-20	mA
I <sub>OK</sub>	Output clamp current	(V <sub>O</sub> < 0 or V <sub>O</sub> > V <sub>CC</sub> )		±20	mA
Io	Continuous output current	(V <sub>O</sub> = 0 to V <sub>CC</sub> )		±25	mA
	Continuous current through V <sub>CC</sub> or GND			±50	mA
T <sub>stg</sub>	Storage temperature range		-65	150	°C

<sup>(1)</sup> Stresses beyond those listed under "absolute maximum ratings" may cause permanent damage to the device. These are stress ratings only, and functional operation of the device at these or any other conditions beyond those indicated under "recommended operating conditions" is not implied. Exposure to absolute-maximum-rated conditions for extended periods may affect device reliability.

### 4.2 ESD Ratings

			VALUE	UNIT
V <sub>(ESE</sub>	) Electrostatic discharge	Human body model (HBM), per AEC Q100-002 <sup>1</sup>	±2000	V

<sup>(1)</sup> AEC Q100-002 indicates that HBM stressing must be in accordance with the ANSI/ESDA/JEDEC JS-001 specification.

### 4.3 Recommended Operating Conditions

over recommended operating free-air temperature range (unless otherwise noted)<sup>1</sup>

			MIN	MAX	UNIT	
V <sub>CC</sub>	Supply voltage		2	5.5	V	
		V <sub>CC</sub> = 2 V	1.5			
$V_{IH}$	High-level input voltage	V <sub>CC</sub> = 3 V	2.1		V	
		V <sub>CC</sub> = 5.5 V	3.85			
		V <sub>CC</sub> = 2 V		0.5		
V <sub>IL</sub>	Low-level input voltage	V <sub>CC</sub> = 3 V		0.9	V	
		V <sub>CC</sub> = 5.5 V		1.65		
VI	Input voltage	·	0	5.5	V	
Vo	Output voltage		0	V <sub>CC</sub>	V	
		V <sub>CC</sub> = 2 V		-50	mA	
I <sub>OH</sub>	High-level output current	V <sub>CC</sub> = 3.3 V ± 0.3 V		-4	A	
		V <sub>CC</sub> = 5 V ± 0.5 V		-8	mA	
		V <sub>CC</sub> = 2 V		50	mA	
I <sub>OL</sub>	Low-level output current	V <sub>CC</sub> = 3.3 V ± 0.3 V		4	mA	
		$V_{CC} = 5 V \pm 0.5 V$		8	ША	
Δt/Δν	Input transition rise or fall rate	$V_{CC} = 3.3 \text{ V} \pm 0.3 \text{ V}$		100	ns/V	
ΔΙ/Δ۷	input transition rise of fail rate	V <sub>CC</sub> = 5 V ± 0.5 V		20	115/ V	
T <sub>A</sub>	Operating free-air temperature		-40	125	°C	

<sup>(1)</sup> All unused inputs of the device must be held at V<sub>CC</sub> or GND to ensure proper device operation. Refer to the TI application report, *Implications of Slow or Floating CMOS Inputs*, literature number SCBA004.

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<sup>(2)</sup> The input and output voltage ratings may be exceeded if the input and output current ratings are observed.



### 4.4 Thermal Information

THERMAL METRIC(1)		SI	SN74AHC08Q-Q1				
		D (SOIC)	PW (TSSOP)	BQA (WQFN)	UNIT		
			14 PINS	14 PINS			
$R_{\theta JA}$	Junction-to-ambient thermal resistance	86	147.7	88.3	°C/W		

<sup>(1)</sup> For more information about traditional and new thermal metrics, see the IC Package Thermal Metrics

#### 4.5 Electrical Characteristics

over recommended operating free-air temperature range (unless otherwise noted)

PAR	RAMETER	TEST CONDITIONS		V <sub>cc</sub>	V <sub>CC</sub> T <sub>A</sub> = 25°C		T <sub>A</sub> = -40°C TO 125°C		T <sub>A</sub> = -40°C TO 85°C		UNIT	
					MIN	TYP	MAX	MIN	MAX	MIN	MAX	
				2 V	1.9	2		1.9		1.9		
		$I_{OH} = -50 \mu A$		3 V	2.9	3		2.9		2.9		
V <sub>OH</sub>				4.5 V	4.4	4.5		4.4		4.4		V
		I <sub>OH</sub> = -4 mA		3 V	2.58			2.48		2.48		
		I <sub>OH</sub> = −8 mA		4.5 V	3.94			3.8		3.8		
		I <sub>OL</sub> = 50 μA		2 V			0.1		0.1		0.1	
				3 V			0.1		0.1		0.1	
V <sub>OL</sub>				4.5 V			0.1		0.1		0.1	V
		I <sub>OL</sub> = 4 mA	I <sub>OL</sub> = 4 mA				0.36		0.5		0.44	
		I <sub>OL</sub> = 8 mA	I <sub>OL</sub> = 8 mA				0.36	-	0.5		0.44	
I <sub>I</sub>	A or B inputs	V <sub>I</sub> = 5.5 V or GND		0 V to 5.5 V			±0.1		±1		±1	μΑ
Icc	-1	$V_I = V_{CC}$ or GND,	I <sub>O</sub> = 0	5.5 V			2		20		20	μΑ
Ci		$V_I = V_{CC}$ or GND		5 V		4	10					pF

# 4.6 Switching Characteristics, $V_{CC}$ = 3.3 V ± 0.3 V

over recommended operating free-air temperature range,  $V_{CC}$  = 3.3 V  $\pm$  0.3 V (unless otherwise noted) (see Load Circuit and Voltage Waveforms)

PARAMETER	FROM (INPUT)	TO (OUTPUT)	LOAD CAPACITANCE	TA	= 25°C		T <sub>A</sub> = -4		T <sub>A</sub> = -4		UNIT
	(IIVF O1)	(001701)	CAFACITANCE	MIN	TYP	MAX	MIN	MAX	MIN	MAX	
t <sub>PLH</sub>	A or B	V	C = 15 pE		6.2	8.8	1	10.5	1	10.5	ns
t <sub>PHL</sub>		Ť	C <sub>L</sub> = 15 pF		6.2	8.8	1	10.5	1	10.5	115
t <sub>PLH</sub>	A or B	Υ	C <sub>L</sub> = 50 pF		8.7	12.3	1	14	1	14	no
t <sub>PHL</sub>	AUID				8.7	12.3	1	14	1	14	ns



# 4.7 Switching Characteristics, $V_{CC}$ = 5 V ± 0.5 V

over recommended operating free-air temperature range,  $V_{CC}$  = 5 V  $\pm$  0.5 V (unless otherwise noted) (see Load Circuit and Voltage Waveforms)

PARAMETER	FROM (INPUT)	TO (OUTPUT)	LOAD CAPACITANCE	T <sub>A</sub> :	= 25°C		T <sub>A</sub> = -40		T <sub>A</sub> = -40		UNIT
	(INFOT)	(OUTPUT)	CAPACITANCE	MIN	TYP	MAX	MIN	MAX	MIN	MAX	
t <sub>PLH</sub>	A or B	Y C <sub>L</sub> = 15 pF	B Y C <sub>L</sub> = 15 pF		4.3	5.9	1	7	1	7	no
t <sub>PHL</sub>	AUID			C <sub>L</sub> = 15 pr		4.3	5.9	1	7	1	7
t <sub>PLH</sub>	A or B	Y C <sub>L</sub> = 50 pF	C = 50 pF		5.8	7.9	1	9	1	9	ne
t <sub>PHL</sub>	AUID			5.8	7.9	1	9	1	9	ns	

### 4.8 Noise Characteristics

 $V_{CC} = 5 \text{ V}, C_L = 50 \text{ pF}, T_A = 25^{\circ}\text{C}^1$ 

	PARAMETER	MIN	MAX	UNIT
V <sub>OL(P)</sub>	Quiet output, maximum dynamic V <sub>OL</sub>		0.8	V
V <sub>OL(V)</sub>	Quiet output, minimum dynamic V <sub>OL</sub>		-0.8	V
V <sub>IH(D)</sub>	High-level dynamic input voltage	3.5		V
V <sub>IL(D)</sub>	Low-level dynamic input voltage		1.5	V

<sup>(1)</sup> Characteristics are for surface-mount packages only.

### 4.9 Operating Characteristics

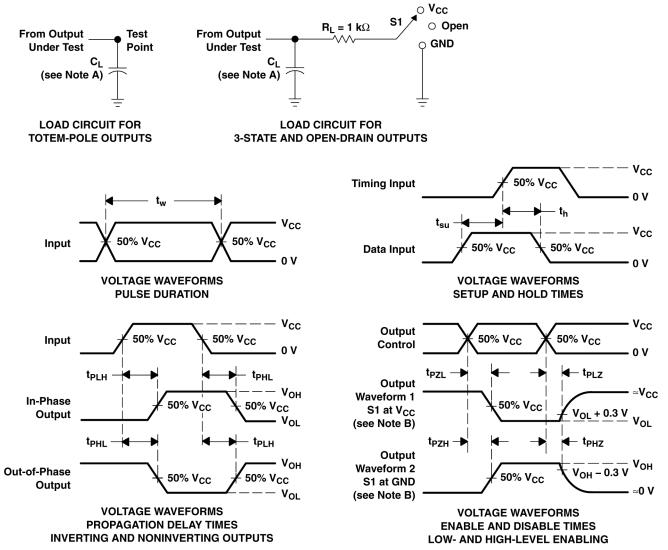
 $V_{CC}$  = 5 V,  $T_A$  = 25°C

	PARAMETER	TEST CONDITIONS	TYP	UNIT
$C_{pd}$	Power dissipation capacitance	No load, f = 1 MHz	18	pF

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#### **5 Parameter Measurement Information**



- C<sub>L</sub> includes probe and jig capacitance.
- B. Waveform 1 is for an output with internal conditions such that the output is low, except when disabled by the output control. Waveform 2 is for an output with internal conditions such that the output is high, except when disabled by the output control.
- C. All input pulses are supplied by generators having the following characteristics: PRR  $\leq$  1 MHz,  $Z_O = 50 \Omega$ ,  $t_f \leq$  3 ns.
- D. The outputs are measured one at a time, with one input transition per measurement.

Figure 5-1. Load Circuit and Voltage Waveforms

TEST	S1
t <sub>PLH</sub> /t <sub>PHL</sub>	Open
t <sub>PLZ</sub> /t <sub>PZL</sub>	V <sub>CC</sub>
t <sub>PHZ</sub> /t <sub>PZH</sub>	GND
Open Drain	V <sub>CC</sub>



# **6 Detailed Description**

# 6.1 Functional Block Diagram

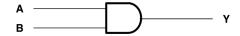


Figure 6-1. Logic Diagram (Positive Logic)

### **6.2 Device Functional Modes**

**Table 6-1. Function Table (Each Gate)** 

INP	UTS	OUTPUT Y			
Α	В	OUIPULT			
Н	Н	Н			
L	X	L			
X	L	L			

### 7 Device and Documentation Support

TI offers an extensive line of development tools. Tools and software to evaluate the performance of the device, generate code, and develop solutions are listed below.

### 7.1 Documentation Support

#### 7.1.1 Related Documentation

The table below lists quick access links. Categories include technical documents, support and community resources, tools and software, and quick access to sample or buy.

#### Table 7-1. Related Links

PARTS	PRODUCT FOLDER	SAMPLE & BUY	TECHNICAL DOCUMENTS	TOOLS & SOFTWARE	SUPPORT & COMMUNITY	
SN74AHC08Q-Q1	Click here	Click here	Click here	Click here	Click here	

### 7.2 Receiving Notification of Documentation Updates

To receive notification of documentation updates, navigate to the device product folder on ti.com. Click on *Notifications* to register and receive a weekly digest of any product information that has changed. For change details, review the revision history included in any revised document.

### 7.3 Support Resources

TI E2E<sup>™</sup> support forums are an engineer's go-to source for fast, verified answers and design help — straight from the experts. Search existing answers or ask your own question to get the quick design help you need.

Linked content is provided "AS IS" by the respective contributors. They do not constitute TI specifications and do not necessarily reflect TI's views; see TI's Terms of Use.

#### 7.4 Trademarks

TI E2E™ is a trademark of Texas Instruments.

All trademarks are the property of their respective owners.

#### 7.5 Electrostatic Discharge Caution



This integrated circuit can be damaged by ESD. Texas Instruments recommends that all integrated circuits be handled with appropriate precautions. Failure to observe proper handling and installation procedures can cause damage.

ESD damage can range from subtle performance degradation to complete device failure. Precision integrated circuits may be more susceptible to damage because very small parametric changes could cause the device not to meet its published specifications.

### 7.6 Glossary

TI Glossary

This glossary lists and explains terms, acronyms, and definitions.

#### 8 Revision History

NOTE: Page numbers for previous revisions may differ from page numbers in the current version.

С	hanges from Revision D (June 2023) to Revision E (May 2024)	Page
•	Added body size to Package Information table	1
•	Added BQA pinout to Pin Configuration and Functions section	3

### Changes from Revision C (April 2008) to Revision D (June 2023)

Page

 Added Package Information table, Pin Functions table, ESD Ratings table, Thermal Information table, Device Functional Modes, Device and Documentation Support section, and Mechanical, Packaging, and Orderable Information section



•	Added BQA package to Package Information table	1
•	Updated thermal values for PW package from RθJA = 113 to 147.7, all values in °C/W	5
	Added thermal value for RθJA: BQA = 88.3, all values in °C/W	

# 9 Mechanical, Packaging, and Orderable Information

The following pages include mechanical, packaging, and orderable information. This information is the most current data available for the designated devices. This data is subject to change without notice and revision of this document. For browser-based versions of this data sheet, refer to the left-hand navigation.

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#### PACKAGING INFORMATION

Orderable part number	Status	Material type	Package   Pins	Package qty   Carrier	RoHS	Lead finish/	MSL rating/	Op temp (°C)	Part marking
	(1)	(2)			(3)	Ball material	Peak reflow		(6)
						(4)	(5)		
SN74AHC08QDRG4Q1	Active	Production	SOIC (D)   14	2500   LARGE T&R	Yes	NIPDAU	Level-1-260C-UNLIM	-	AHC08Q
SN74AHC08QDRG4Q1.A	Active	Production	SOIC (D)   14	2500   LARGE T&R	Yes	NIPDAU	Level-1-260C-UNLIM	-40 to 125	AHC08Q
SN74AHC08QDRQ1	Active	Production	SOIC (D)   14	2500   LARGE T&R	Yes	NIPDAU	Level-1-260C-UNLIM	-40 to 125	AHC08Q
SN74AHC08QDRQ1.A	Active	Production	SOIC (D)   14	2500   LARGE T&R	Yes	NIPDAU	Level-1-260C-UNLIM	-40 to 125	AHC08Q
SN74AHC08QPWRG4Q1	Active	Production	TSSOP (PW)   14	2000   LARGE T&R	Yes	NIPDAU	Level-1-260C-UNLIM	-40 to 125	HA08Q
SN74AHC08QPWRG4Q1.A	Active	Production	TSSOP (PW)   14	2000   LARGE T&R	Yes	NIPDAU	Level-1-260C-UNLIM	-40 to 125	HA08Q
SN74AHC08QPWRQ1	Active	Production	TSSOP (PW)   14	2000   LARGE T&R	Yes	NIPDAU	Level-1-260C-UNLIM	-40 to 125	HA08Q
SN74AHC08QPWRQ1.A	Active	Production	TSSOP (PW)   14	2000   LARGE T&R	Yes	NIPDAU	Level-1-260C-UNLIM	-40 to 125	HA08Q
SN74AHC08QPWRQ1.B	Active	Production	TSSOP (PW)   14	2000   LARGE T&R	-	NIPDAU	Level-1-260C-UNLIM	-40 to 125	HA08Q
SN74AHC08QWBQARQ1	Active	Production	WQFN (BQA)   14	3000   LARGE T&R	Yes	NIPDAU	Level-1-260C-UNLIM	-40 to 125	AHC08Q
SN74AHC08QWBQARQ1.A	Active	Production	WQFN (BQA)   14	3000   LARGE T&R	Yes	NIPDAU	Level-1-260C-UNLIM	-40 to 125	AHC08Q

<sup>(1)</sup> Status: For more details on status, see our product life cycle.

Multiple part markings will be inside parentheses. Only one part marking contained in parentheses and separated by a "~" will appear on a part. If a line is indented then it is a continuation of the previous line and the two combined represent the entire part marking for that device.

<sup>(2)</sup> Material type: When designated, preproduction parts are prototypes/experimental devices, and are not yet approved or released for full production. Testing and final process, including without limitation quality assurance, reliability performance testing, and/or process qualification, may not yet be complete, and this item is subject to further changes or possible discontinuation. If available for ordering, purchases will be subject to an additional waiver at checkout, and are intended for early internal evaluation purposes only. These items are sold without warranties of any kind.

<sup>(3)</sup> RoHS values: Yes, No, RoHS Exempt. See the TI RoHS Statement for additional information and value definition.

<sup>(4)</sup> Lead finish/Ball material: Parts may have multiple material finish options. Finish options are separated by a vertical ruled line. Lead finish/Ball material values may wrap to two lines if the finish value exceeds the maximum column width.

<sup>(5)</sup> MSL rating/Peak reflow: The moisture sensitivity level ratings and peak solder (reflow) temperatures. In the event that a part has multiple moisture sensitivity ratings, only the lowest level per JEDEC standards is shown. Refer to the shipping label for the actual reflow temperature that will be used to mount the part to the printed circuit board.

<sup>(6)</sup> Part marking: There may be an additional marking, which relates to the logo, the lot trace code information, or the environmental category of the part.



## **PACKAGE OPTION ADDENDUM**

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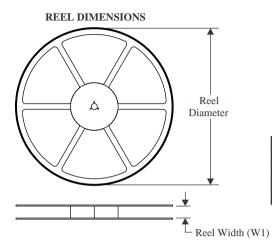
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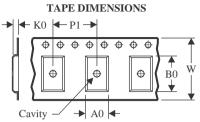
In no event shall TI's liability arising out of such information exceed the total purchase price of the TI part(s) at issue in this document sold by TI to Customer on an annual basis.

# **PACKAGE MATERIALS INFORMATION**

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### TAPE AND REEL INFORMATION





A0	Dimension designed to accommodate the component width
В0	Dimension designed to accommodate the component length
K0	Dimension designed to accommodate the component thickness
W	Overall width of the carrier tape
P1	Pitch between successive cavity centers

#### QUADRANT ASSIGNMENTS FOR PIN 1 ORIENTATION IN TAPE



#### \*All dimensions are nominal

Device	Package Type	Package Drawing		SPQ	Reel Diameter (mm)	Reel Width W1 (mm)	A0 (mm)	B0 (mm)	K0 (mm)	P1 (mm)	W (mm)	Pin1 Quadrant
SN74AHC08QPWRG4Q1	TSSOP	PW	14	2000	330.0	12.4	6.9	5.6	1.6	8.0	12.0	Q1
SN74AHC08QPWRQ1	TSSOP	PW	14	2000	330.0	12.4	6.9	5.6	1.6	8.0	12.0	Q1
SN74AHC08QPWRQ1	TSSOP	PW	14	2000	330.0	12.4	6.9	5.6	1.6	8.0	12.0	Q1
SN74AHC08QWBQARQ1	WQFN	BQA	14	3000	180.0	12.4	2.8	3.3	1.1	4.0	12.0	Q1

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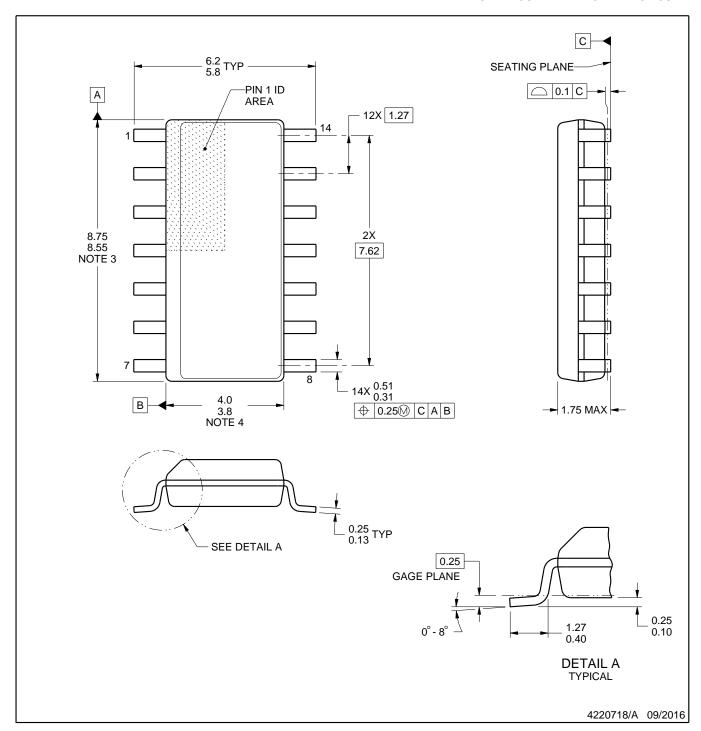


#### \*All dimensions are nominal

Device	Package Type	Package Drawing	Pins	SPQ	Length (mm)	Width (mm)	Height (mm)			
SN74AHC08QPWRG4Q1	TSSOP	PW	14	2000	353.0	353.0	32.0			
SN74AHC08QPWRQ1	TSSOP	PW	14	2000	353.0	353.0	32.0			
SN74AHC08QPWRQ1	TSSOP	PW	14	2000	353.0	353.0	32.0			
SN74AHC08QWBQARQ1	WQFN	BQA	14	3000	210.0	185.0	35.0			



SMALL OUTLINE INTEGRATED CIRCUIT



#### NOTES:

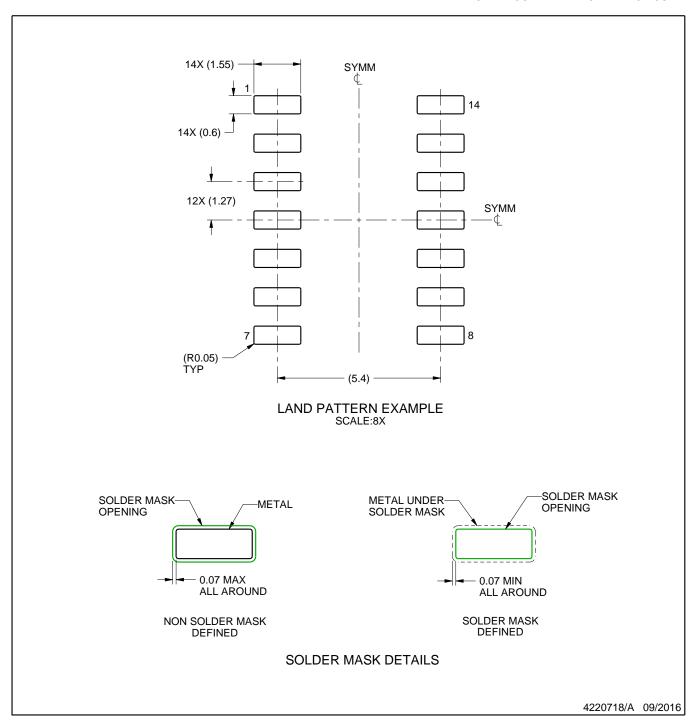
- 1. All linear dimensions are in millimeters. Dimensions in parenthesis are for reference only. Dimensioning and tolerancing per ASME Y14.5M.

  2. This drawing is subject to change without notice.

  3. This dimension does not include mold flash, protrusions, or gate burrs. Mold flash, protrusions, or gate burrs shall not
- exceed 0.15 mm, per side.
- 4. This dimension does not include interlead flash. Interlead flash shall not exceed 0.43 mm, per side.
- 5. Reference JEDEC registration MS-012, variation AB.



SMALL OUTLINE INTEGRATED CIRCUIT



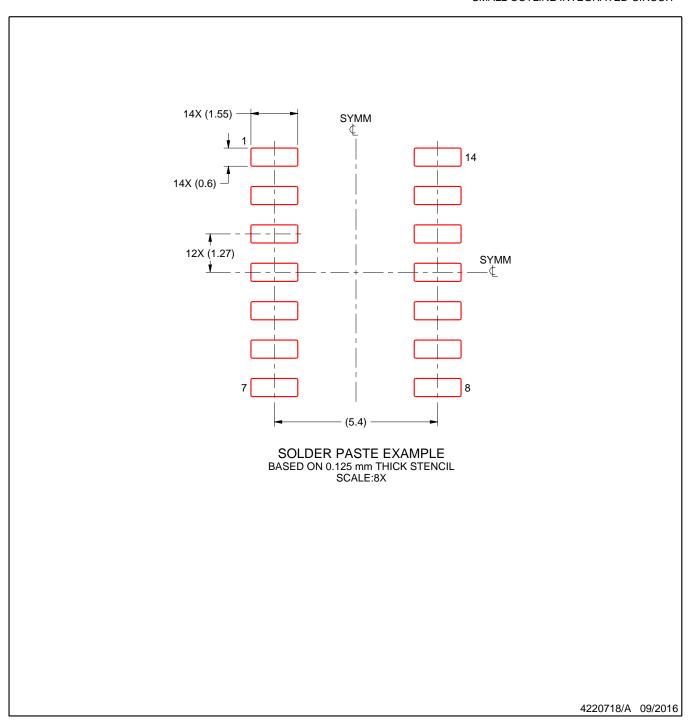
NOTES: (continued)

6. Publication IPC-7351 may have alternate designs.

7. Solder mask tolerances between and around signal pads can vary based on board fabrication site.



SMALL OUTLINE INTEGRATED CIRCUIT



NOTES: (continued)

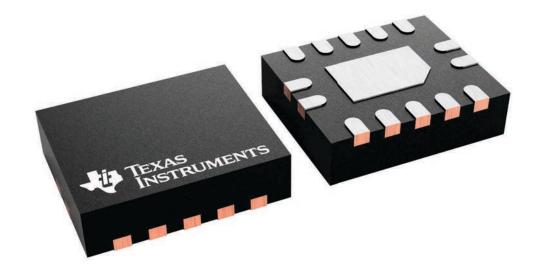
- 8. Laser cutting apertures with trapezoidal walls and rounded corners may offer better paste release. IPC-7525 may have alternate design recommendations.
- 9. Board assembly site may have different recommendations for stencil design.



2.5 x 3, 0.5 mm pitch

PLASTIC QUAD FLATPACK - NO LEAD

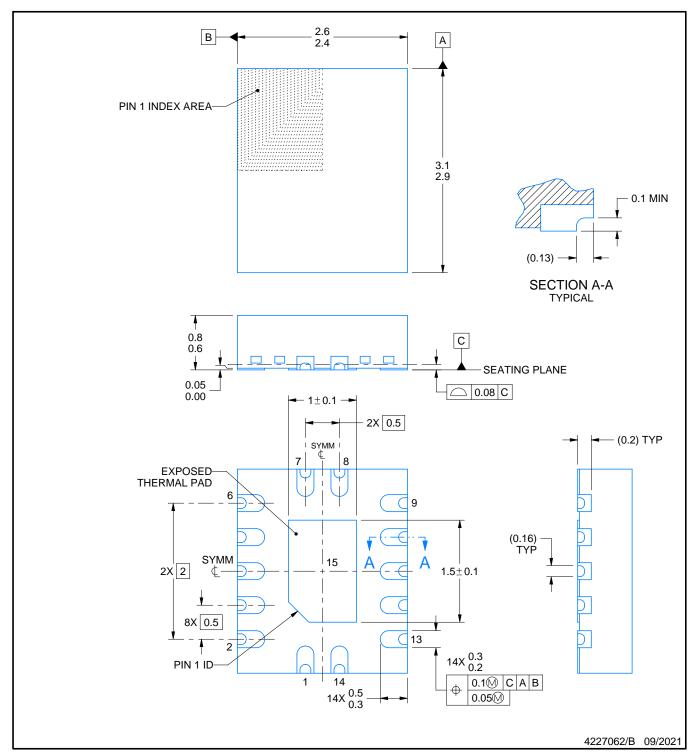
This image is a representation of the package family, actual package may vary. Refer to the product data sheet for package details.



www.ti.com



PLASTIC QUAD FLATPACK - NO LEAD

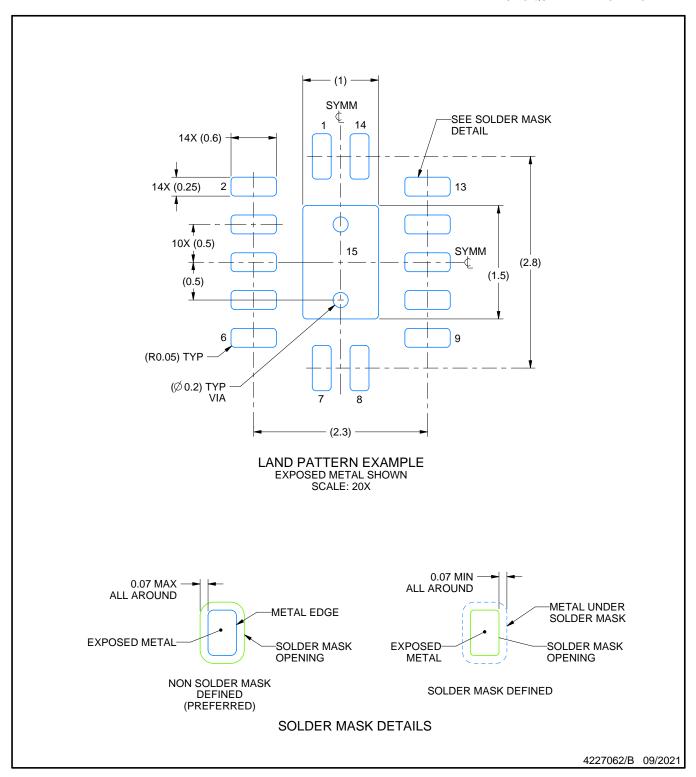


#### NOTES:

- 1. All linear dimensions are in millimeters. Any dimensions in parenthesis are for reference only. Dimensioning and tolerancing per ASME Y14.5M.
  2. This drawing is subject to change without notice.
- 3. The package thermal pad must be soldered to the printed circuit board for thermal and mechanical performance.



PLASTIC QUAD FLATPACK - NO LEAD

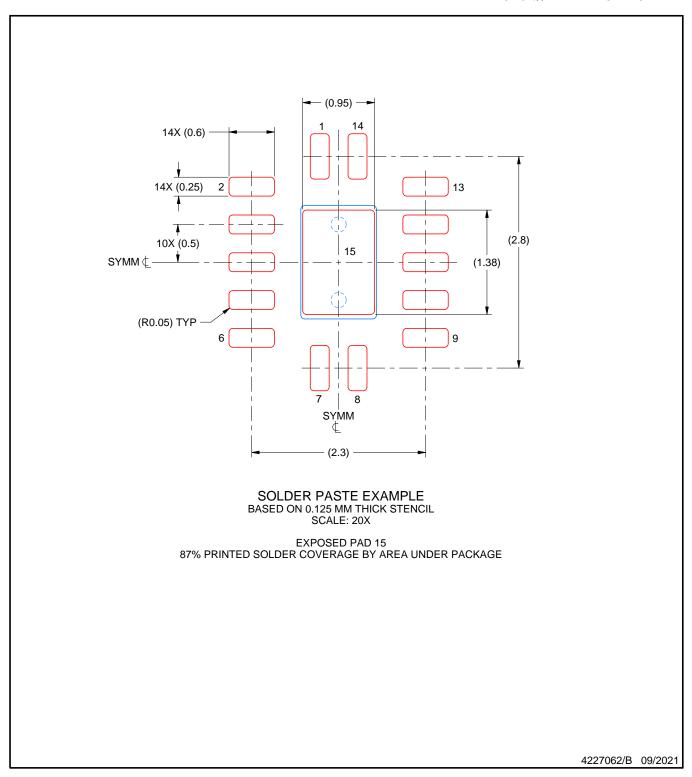


NOTES: (continued)

- 4. This package is designed to be soldered to a thermal pad on the board. For more information, see Texas Instruments literature number SLUA271 (www.ti.com/lit/slua271).
- 5. Vias are optional depending on application, refer to device data sheet. If any vias are implemented, refer to their locations shown on this view. It is recommended that vias under paste be filled, plugged or tented.



PLASTIC QUAD FLATPACK - NO LEAD



NOTES: (continued)

<sup>6.</sup> Laser cutting apertures with trapezoidal walls and rounded corners may offer better paste release. IPC-7525 may have alternate design recommendations.





SMALL OUTLINE PACKAGE



#### NOTES:

- 1. All linear dimensions are in millimeters. Any dimensions in parenthesis are for reference only. Dimensioning and tolerancing per ASME Y14.5M.

  2. This drawing is subject to change without notice.

  3. This dimension does not include mold flash, protrusions, or gate burrs. Mold flash, protrusions, or gate burrs shall not
- exceed 0.15 mm per side.
- 4. This dimension does not include interlead flash. Interlead flash shall not exceed 0.25 mm per side.
- 5. Reference JEDEC registration MO-153.



SMALL OUTLINE PACKAGE



NOTES: (continued)

6. Publication IPC-7351 may have alternate designs.

7. Solder mask tolerances between and around signal pads can vary based on board fabrication site.



SMALL OUTLINE PACKAGE



NOTES: (continued)

- 8. Laser cutting apertures with trapezoidal walls and rounded corners may offer better paste release. IPC-7525 may have alternate design recommendations.
- 9. Board assembly site may have different recommendations for stencil design.



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